## Application/Control No. Applicant(s)/Patent Under Reexamination 10/633,036 YOSHIO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2676 Po-Wei (Dennis) Chen **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Classification Name MM-YYYY 345/593 US-6,031,543 A 02-2000 Miyashita et al. Α US-6,333,752 B1 12-2001 Hasegawa et al. 715/764 В US-С US-D US-E US-F US-G US-US-1 US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х